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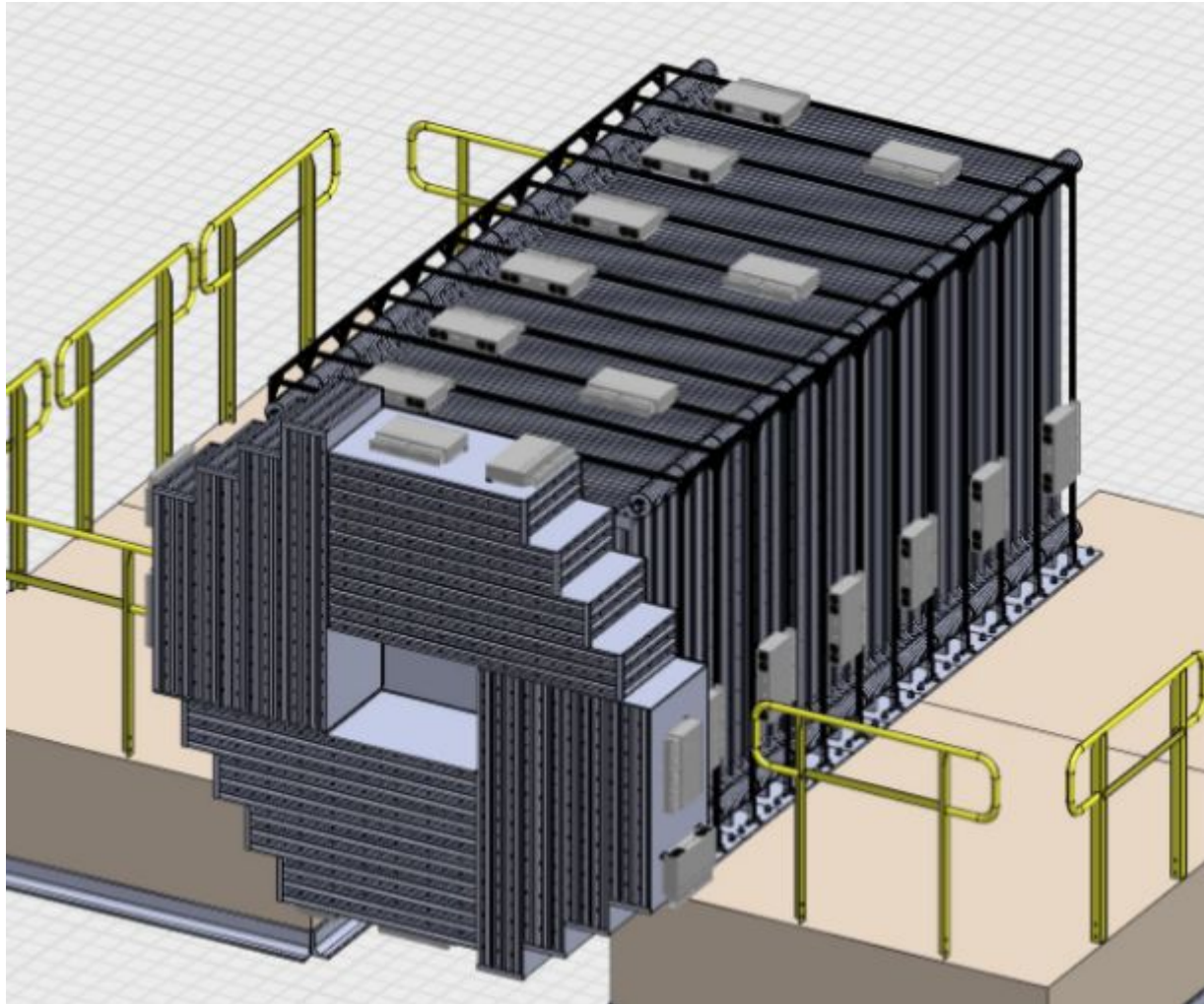
Readout Electronics ASIC Characterization

Verena Hehl, Andreas Pettersson

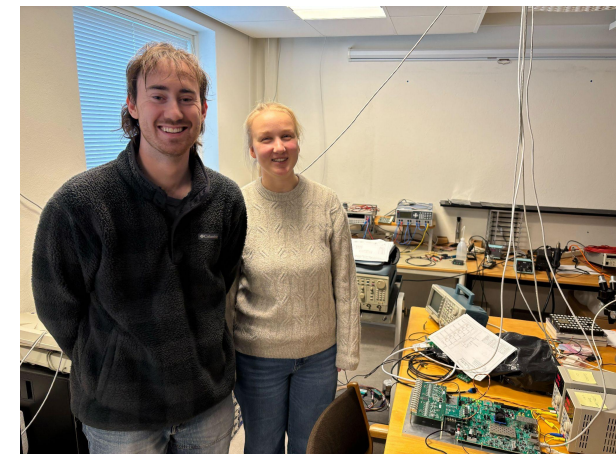
Under supervision of Hannah Herde and Erik Wallin



LDMX's Hadronic Calorimeter

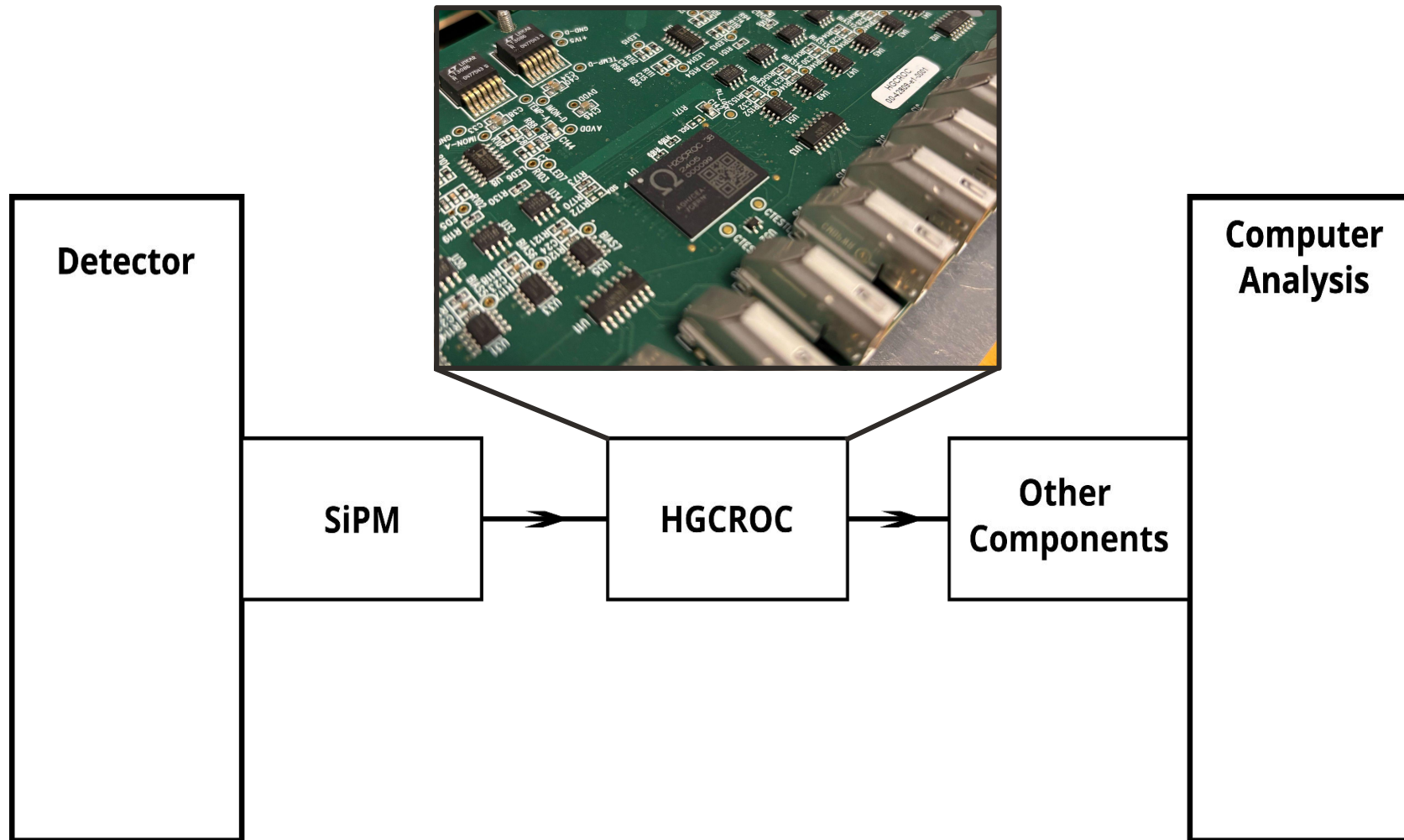


- Scintillator bars with SiPMs at the ends.
- Uses the High Granularity Calorimeter ReadOut Chip (HGCROC).
- In Lund we work on characterizing the HGCROC:



T. Akesson et al. (the LDMX Collaboration). *LDMX – The Light Dark Matter eXperiment*.
arXiv:2508.11833, August 2025.

Readout path

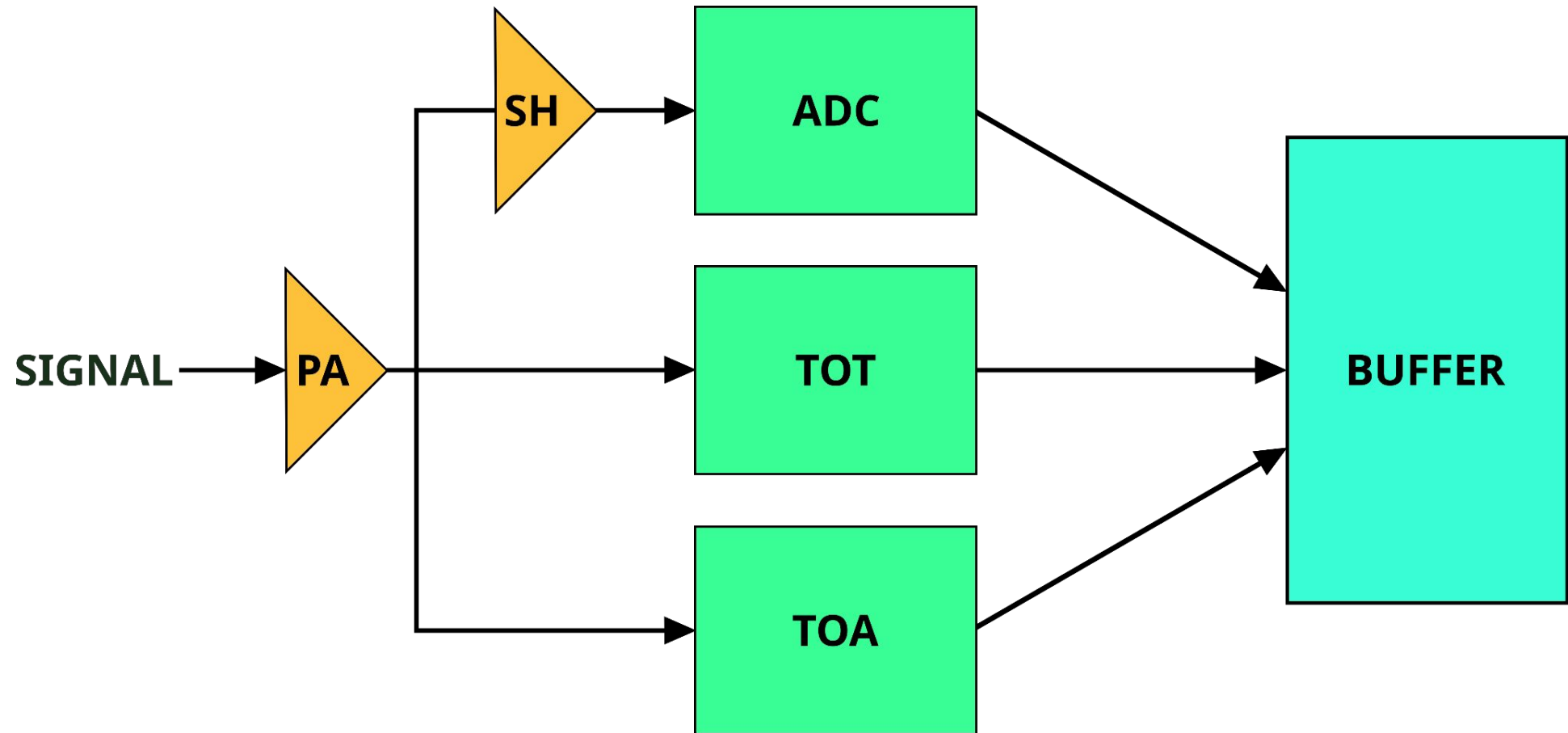


General HGCROC facts:

- 72 channels.
- Includes an ADC and two TDCs.
- Transmits output data at 1.28 GHz



Readout path



Calibration with charge injections

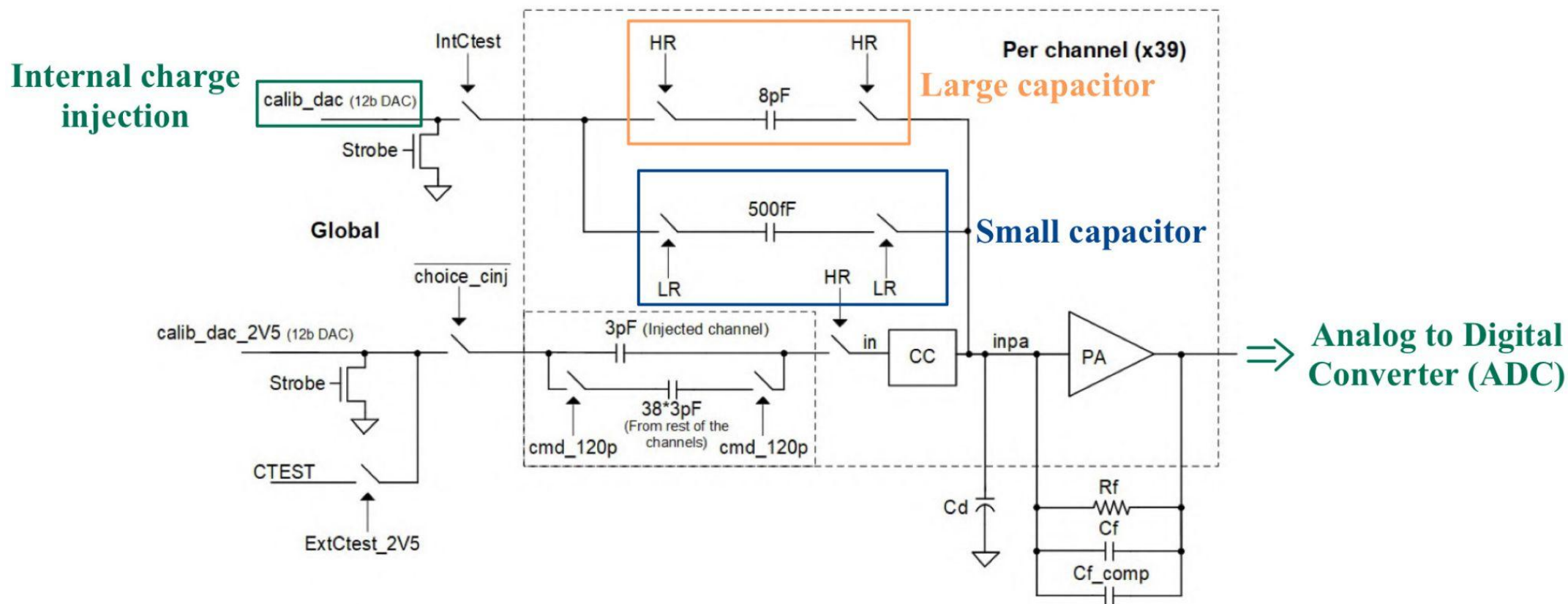
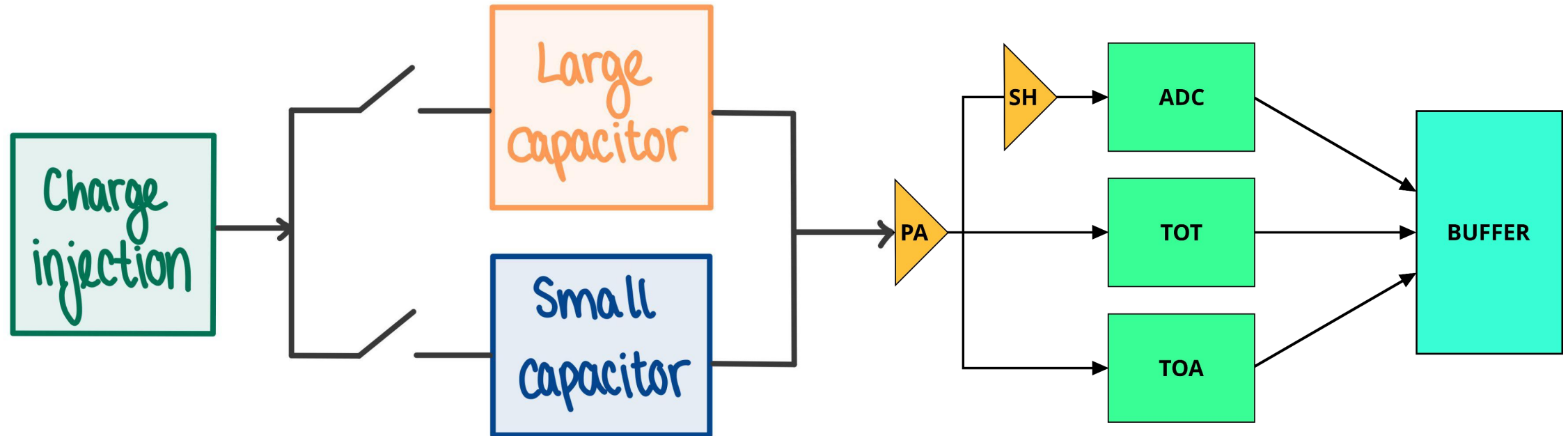


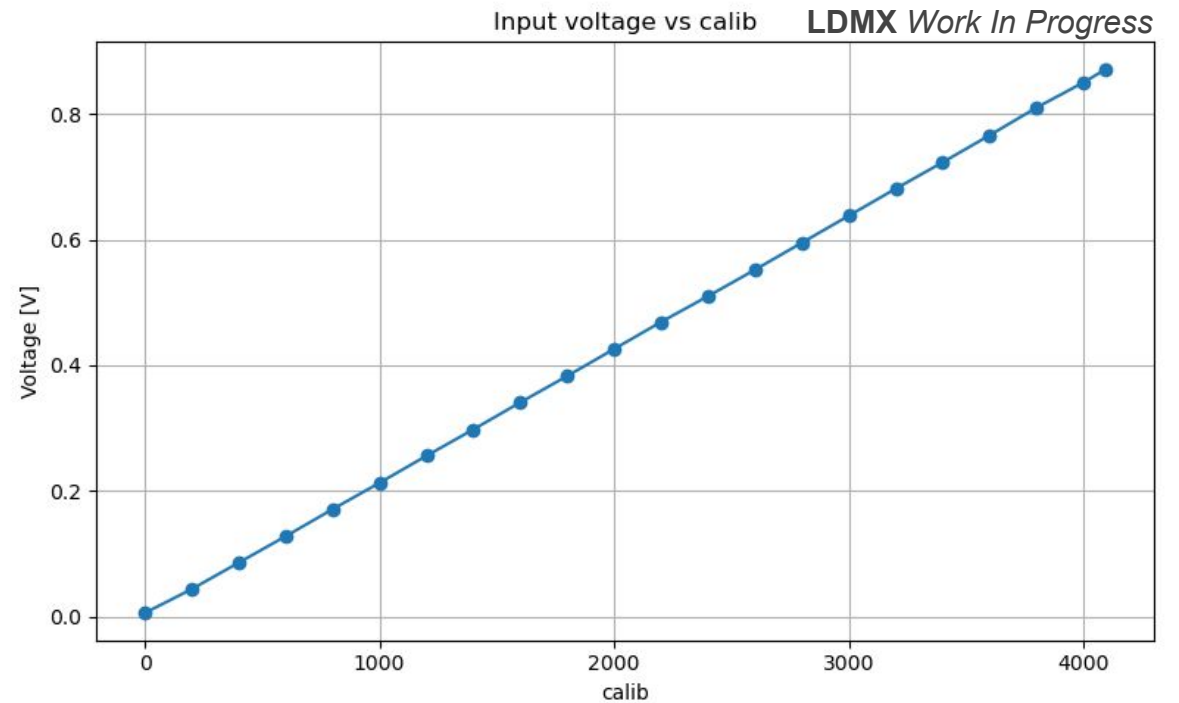
FIGURE 4.43 – *Internal and External injection schematic.*

Charge injection



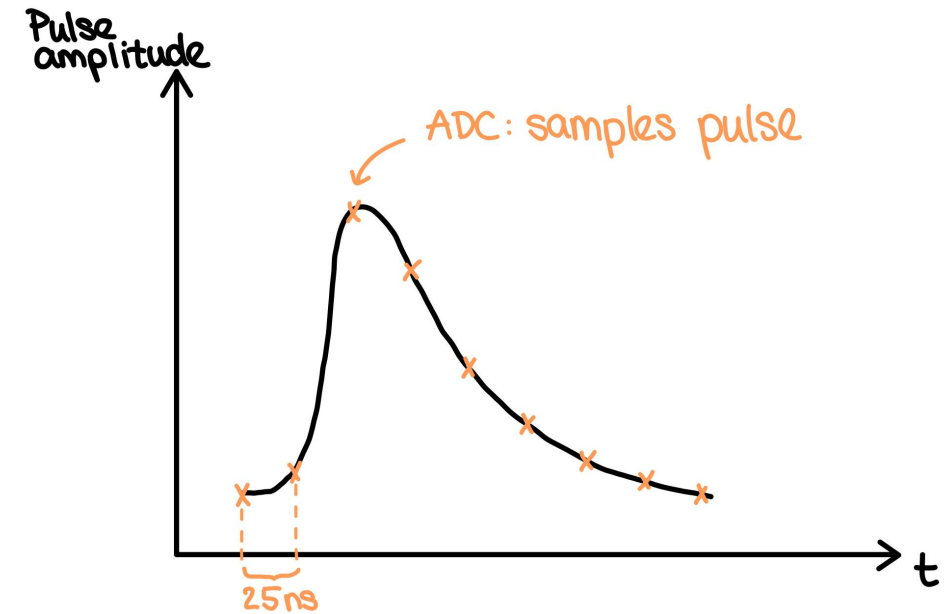
Measuring the input voltage

- Charge injections follow
$$Q = V \cdot C$$
- To vary Q we vary the voltage via the parameter CALIB, corresponding to a 12-bit DAC
- Thus CALIB ranges from 0 to 4095
- Measured corresponding input voltage to each CALIB value
- Linear, with maximum at 0.871 V



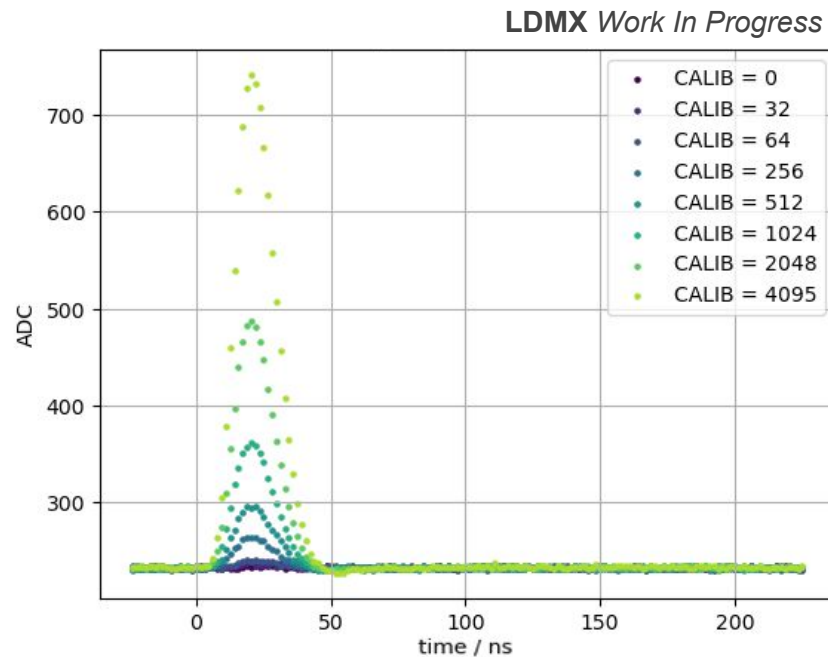
Analog to Digital Converter (ADC)

- ADC samples pulse with a certain time interval
- Converts analog signal into digital signal
- 10-bit ADC, so ADC ranges from 0 to 1023

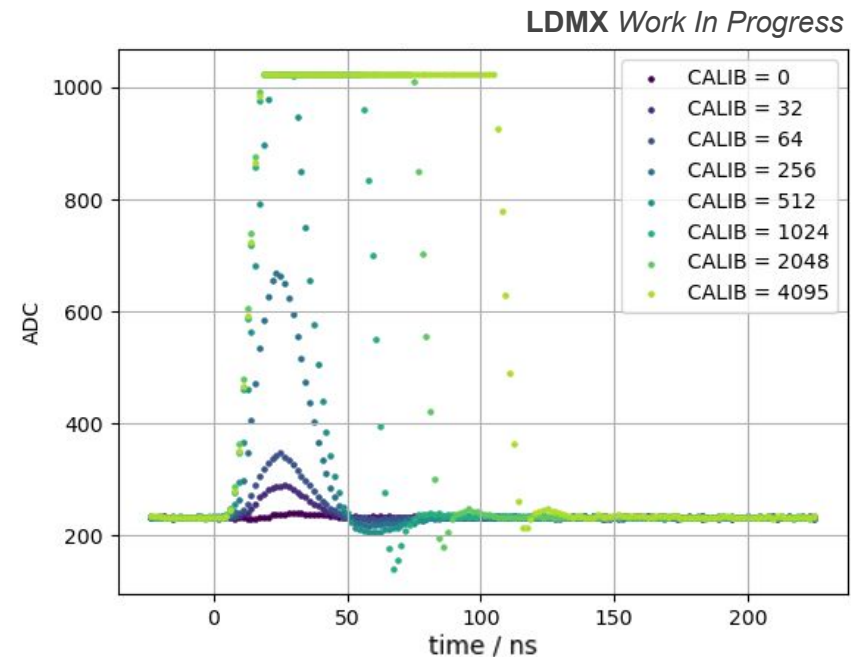


Charge injections: ADC against time

- Plot ADC samples over time
- Did scans on randomly chosen channel for both small and large capacitor
- Saturation only with large capacitor



Small capacitor: 500fF

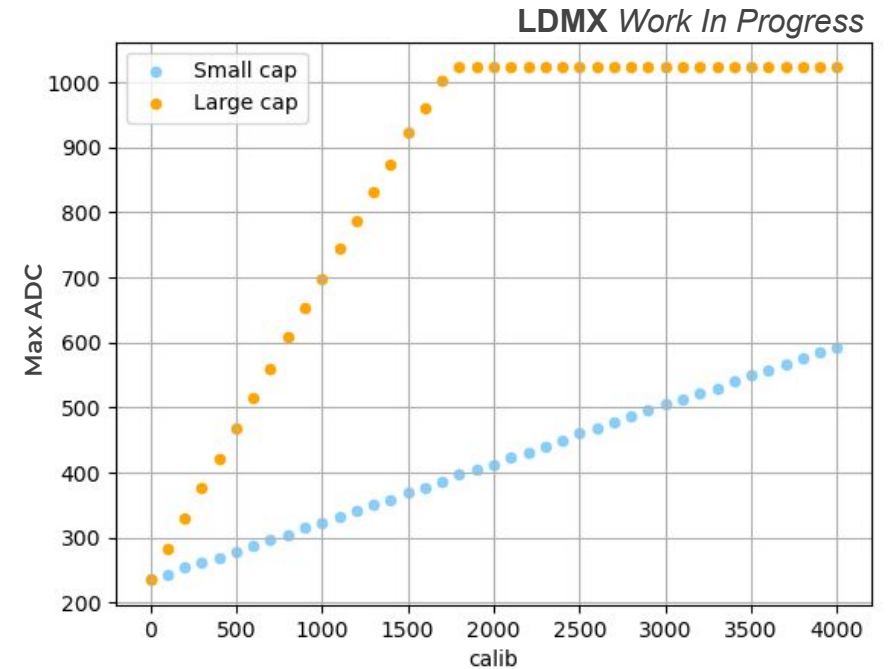
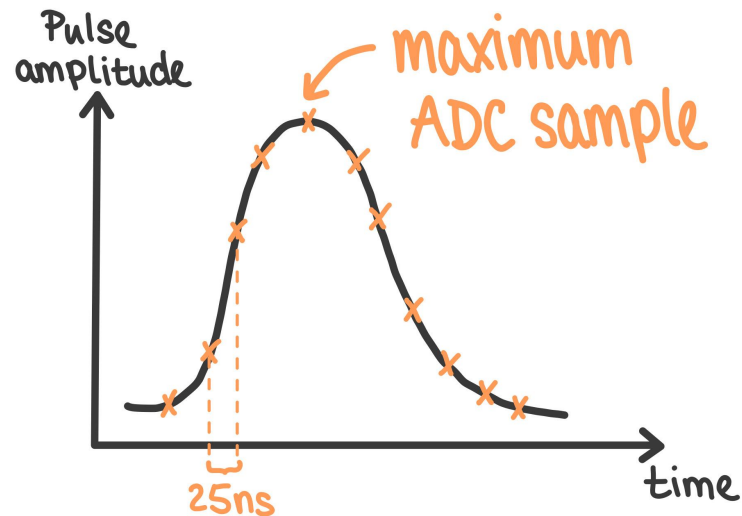


Large capacitor: 8pF



ADC linearity

- Plot the maximum ADC value of each pulse against the injected charge
- Expectation: linear behaviour
- Indeed, both capacitors show linear behaviour for all channels
- Large capacitor saturates the ADC



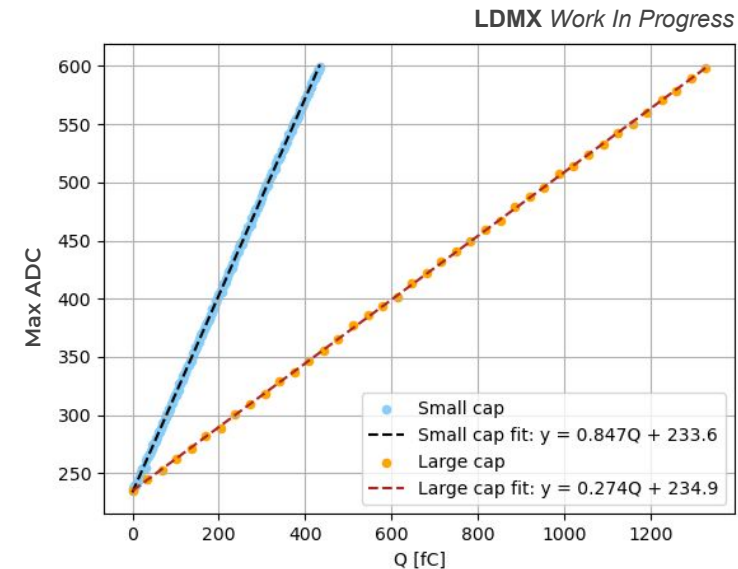
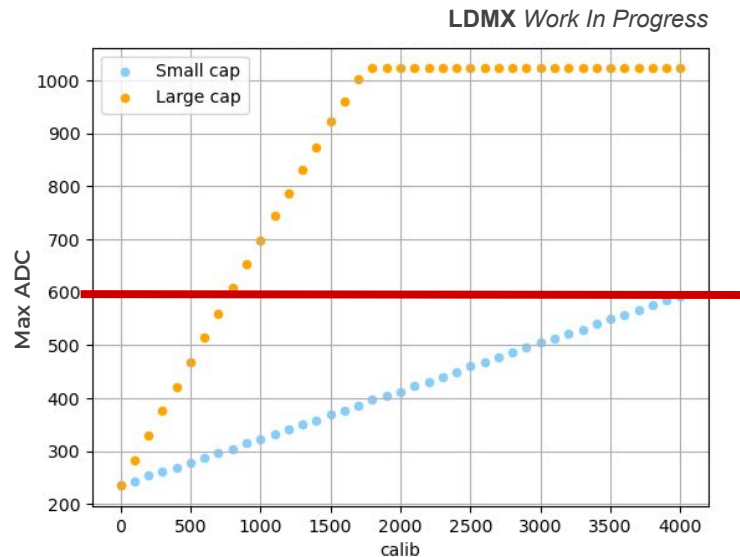
(only every 5th measurement plotted for clarity)



ADC linearity: Convert CALIB to charge

- Use that $V_{max} = 0.871\text{V}$ (measured) and $\text{CALIB}_{max} = 4095$
- Exclude values with $\text{ADC} > 600$
- Conversion will be:

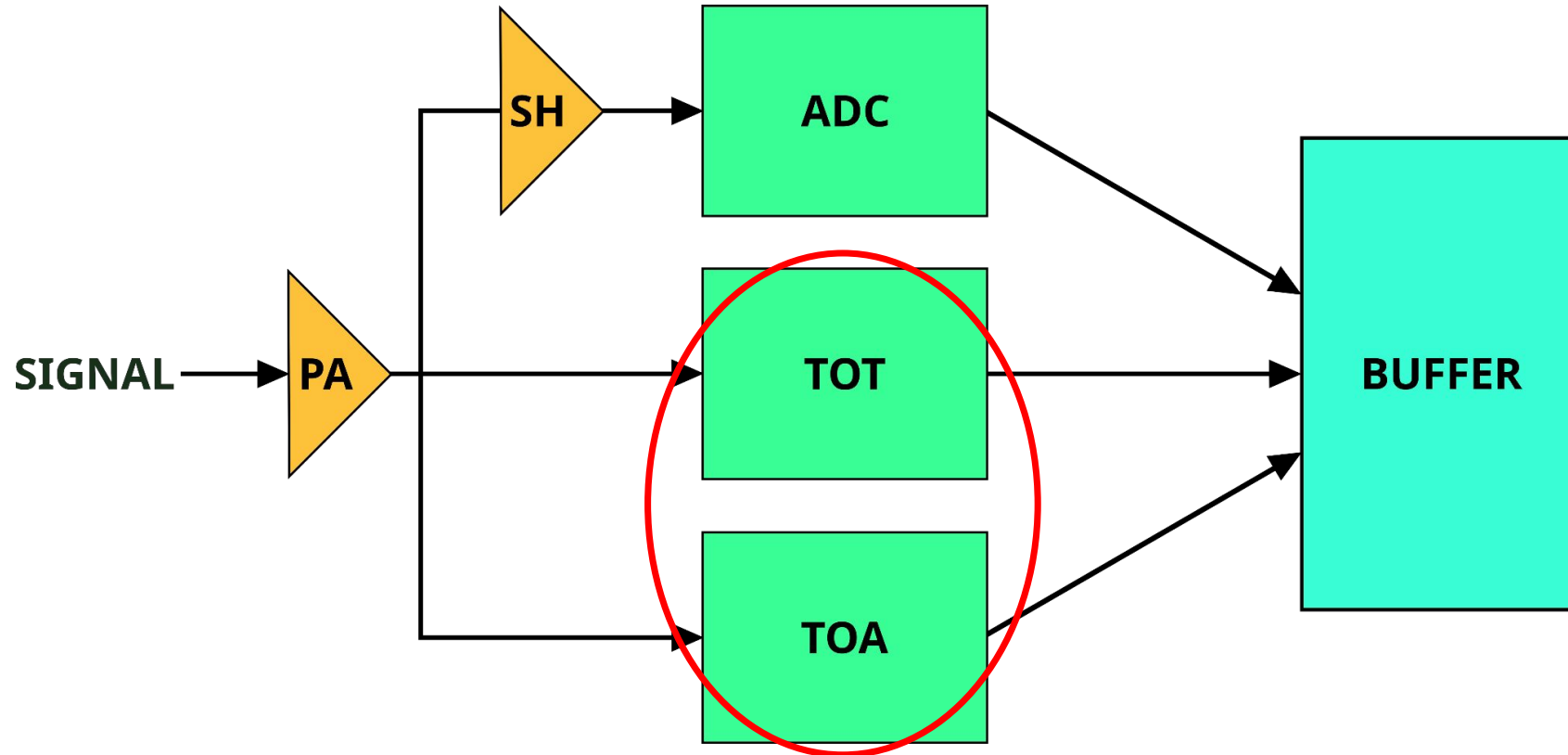
$$Q[\text{fC}] = \frac{\text{CALIB}}{\text{CALIB}_{max}} \cdot C[\text{F}] \cdot V_{max}[\text{V}] \cdot 10^{15}$$



(only every 5th measurement plotted for clarity)



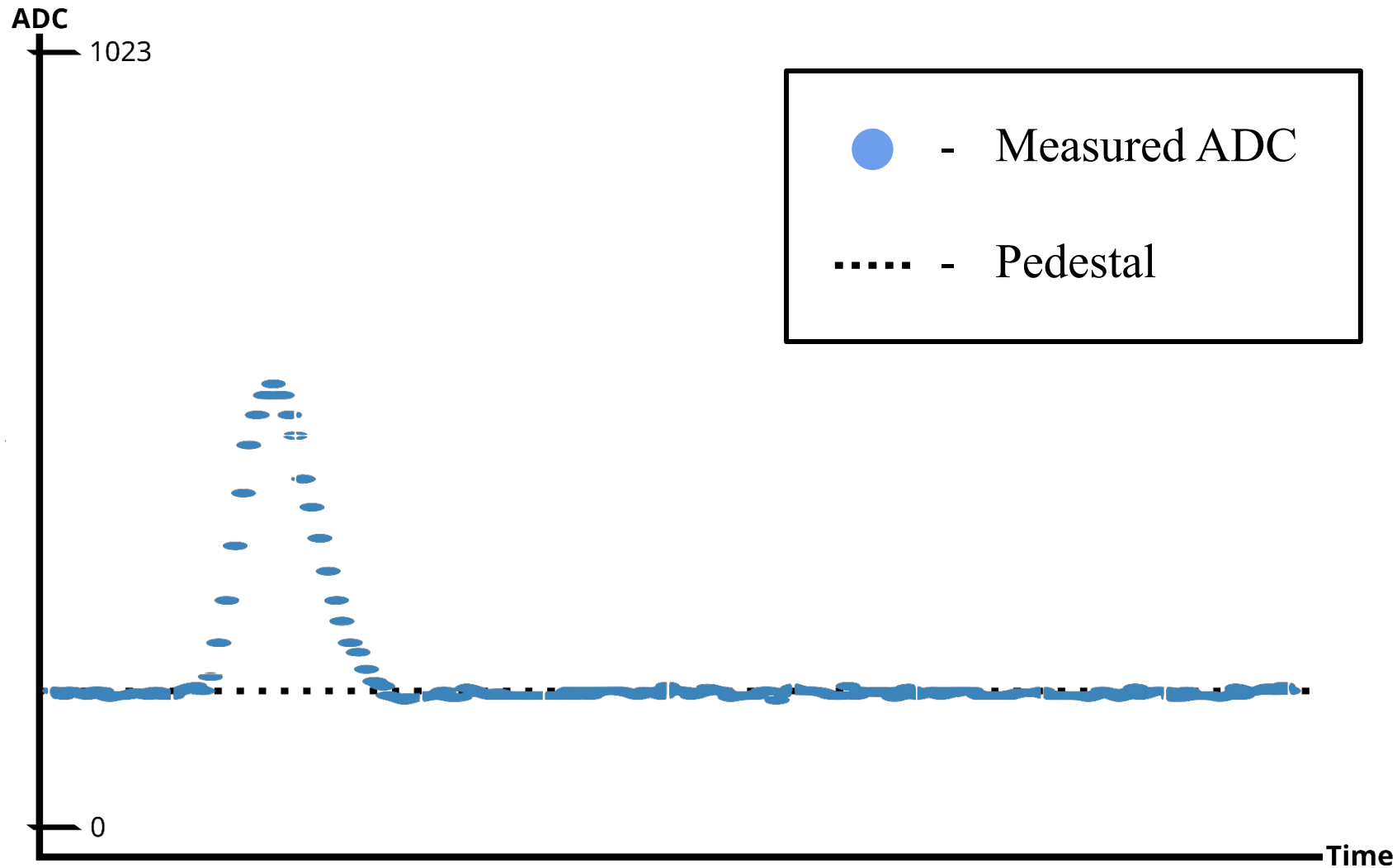
Time Over Threshold



- Time Over Threshold (TOT)
- Time Of Arrival (TOA)



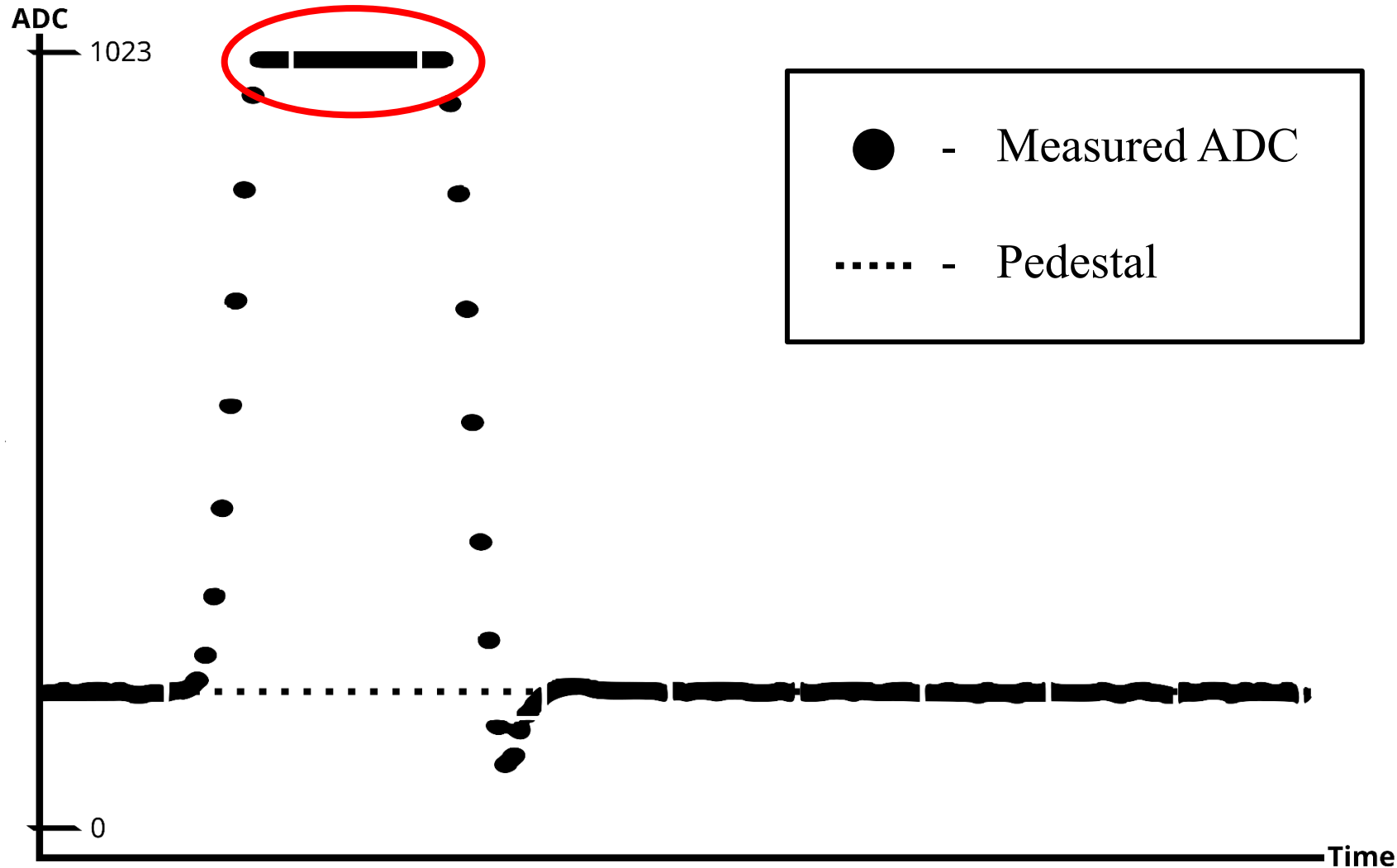
A small pulse



- We have the full information of the pulse shape ✓



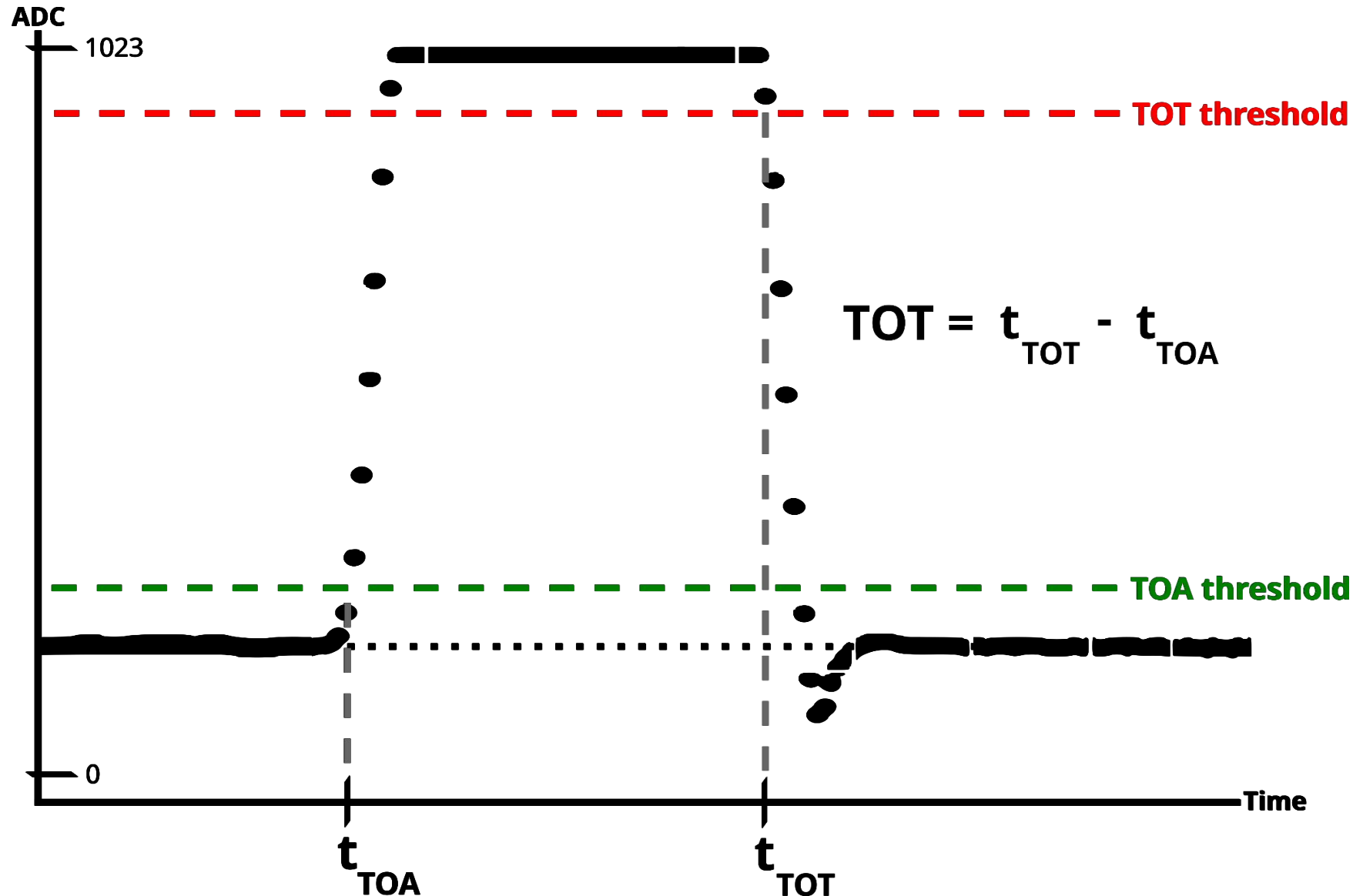
A large pulse



- We're missing information about the pulse shape in the "saturated regime"
- To account for the loss of information, we turn to measurements in time



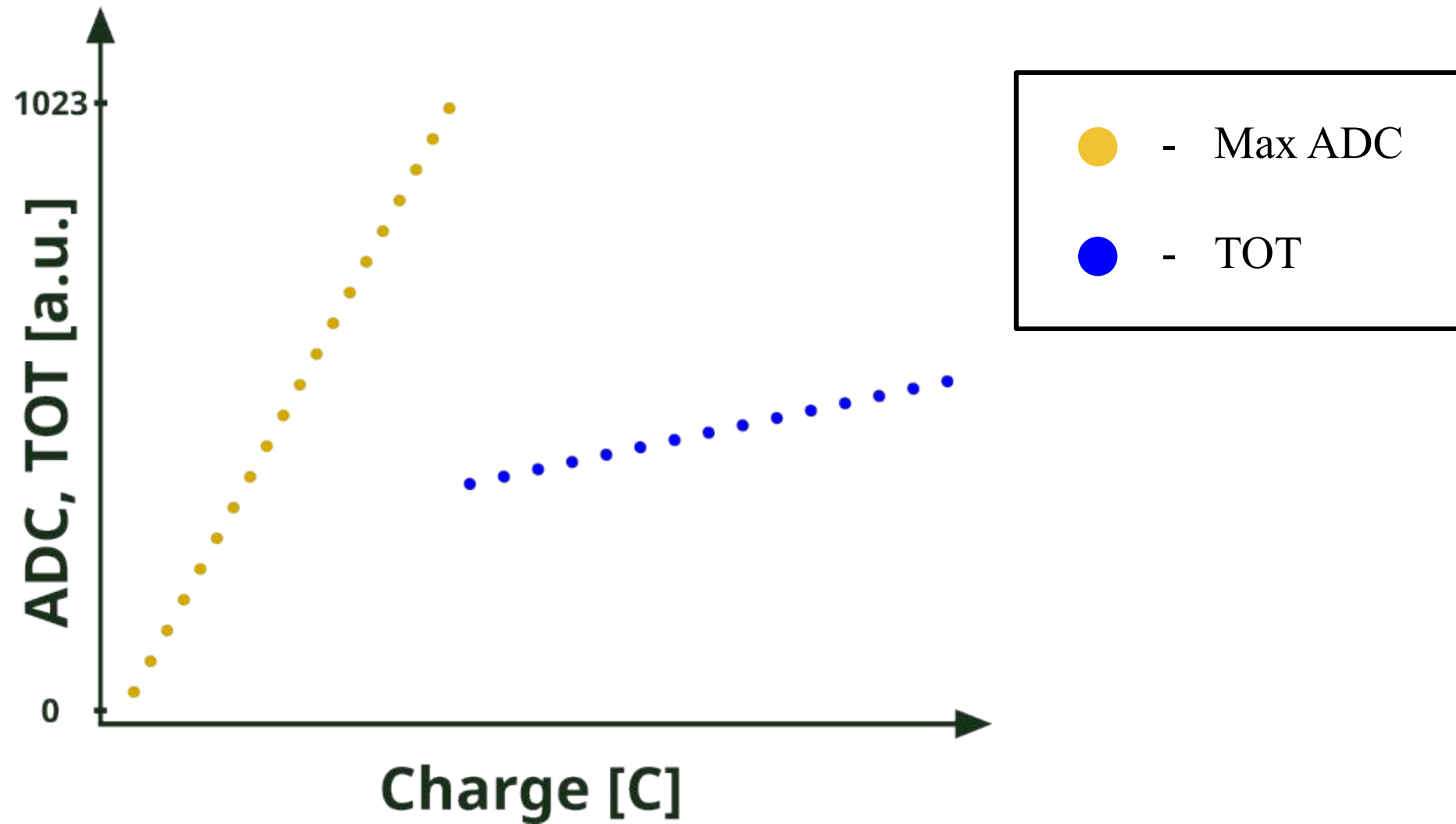
Time Over Threshold



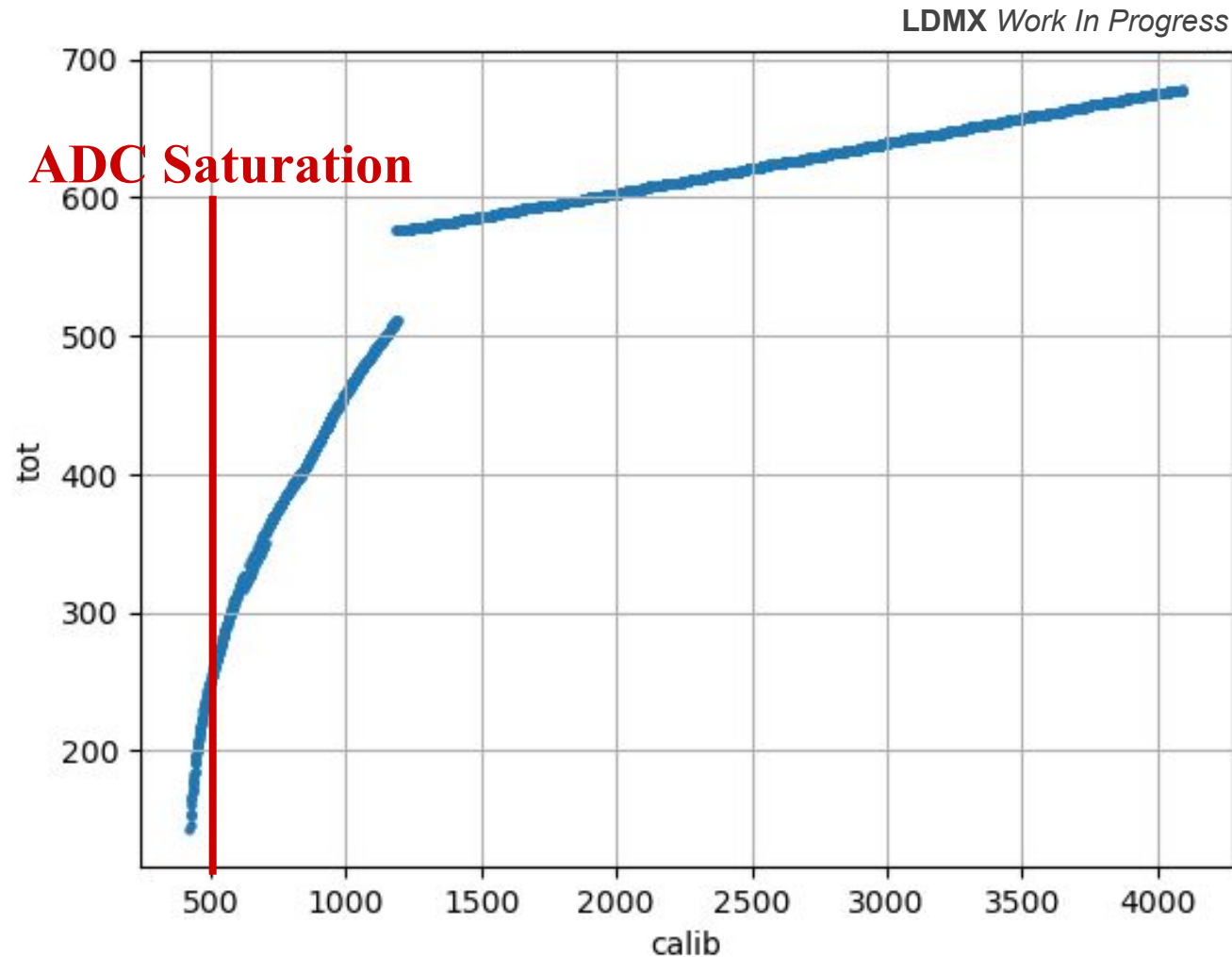
- TOT is calculated as the **time** between the triggers of the TOT threshold and the TOA threshold



TOT expectation



TOT measurements

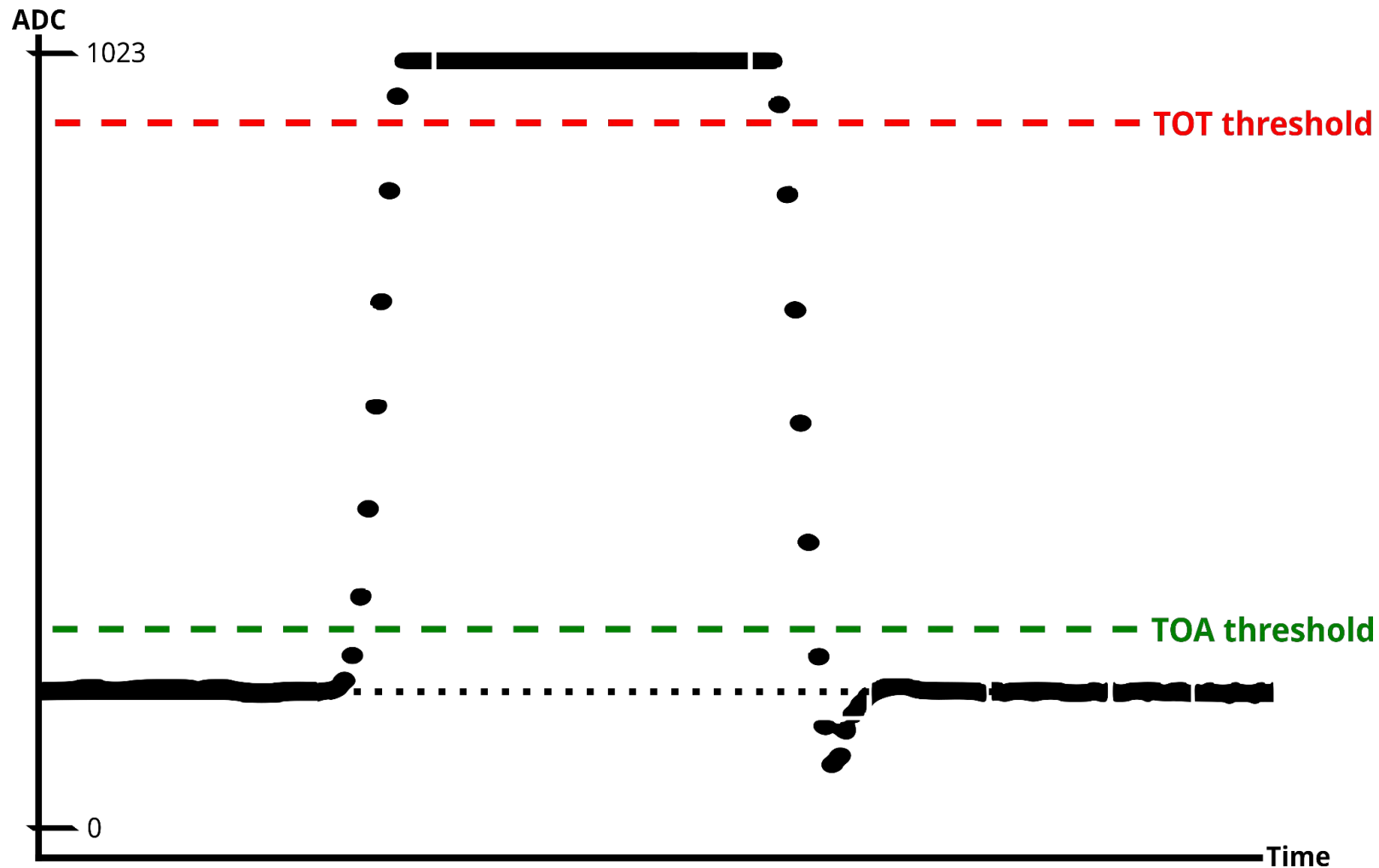


Two regimes:

1. $CALIB < 1190$:
Semi-linear regime.
2. $CALIB \geq 1190$:
Linear regime.



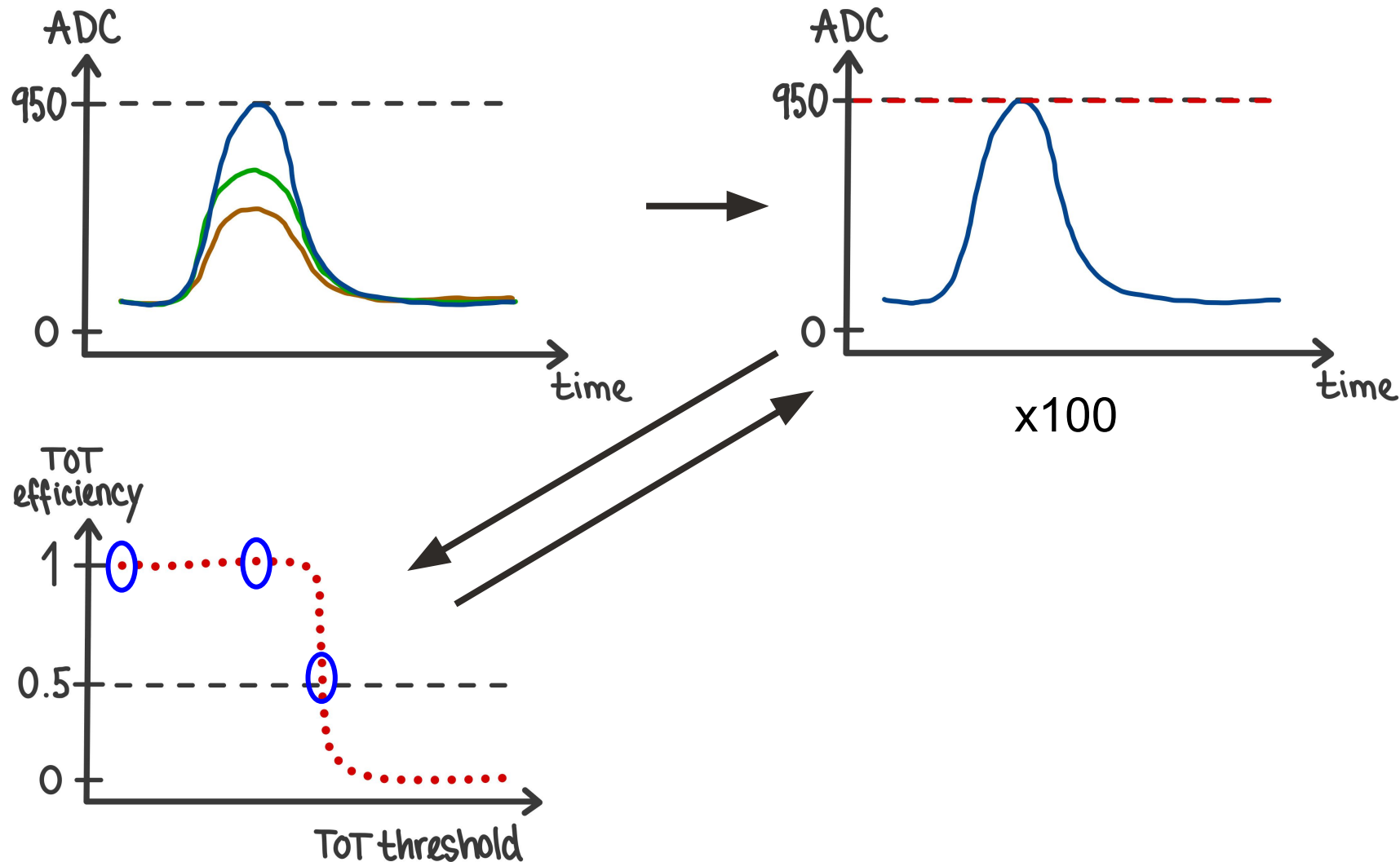
How to set the TOT threshold



- We want a healthy overlap between the ADC and TOT, so we set the TOT threshold slightly below ADC saturation.



How to set the TOT threshold



1. Find the correct CALIB

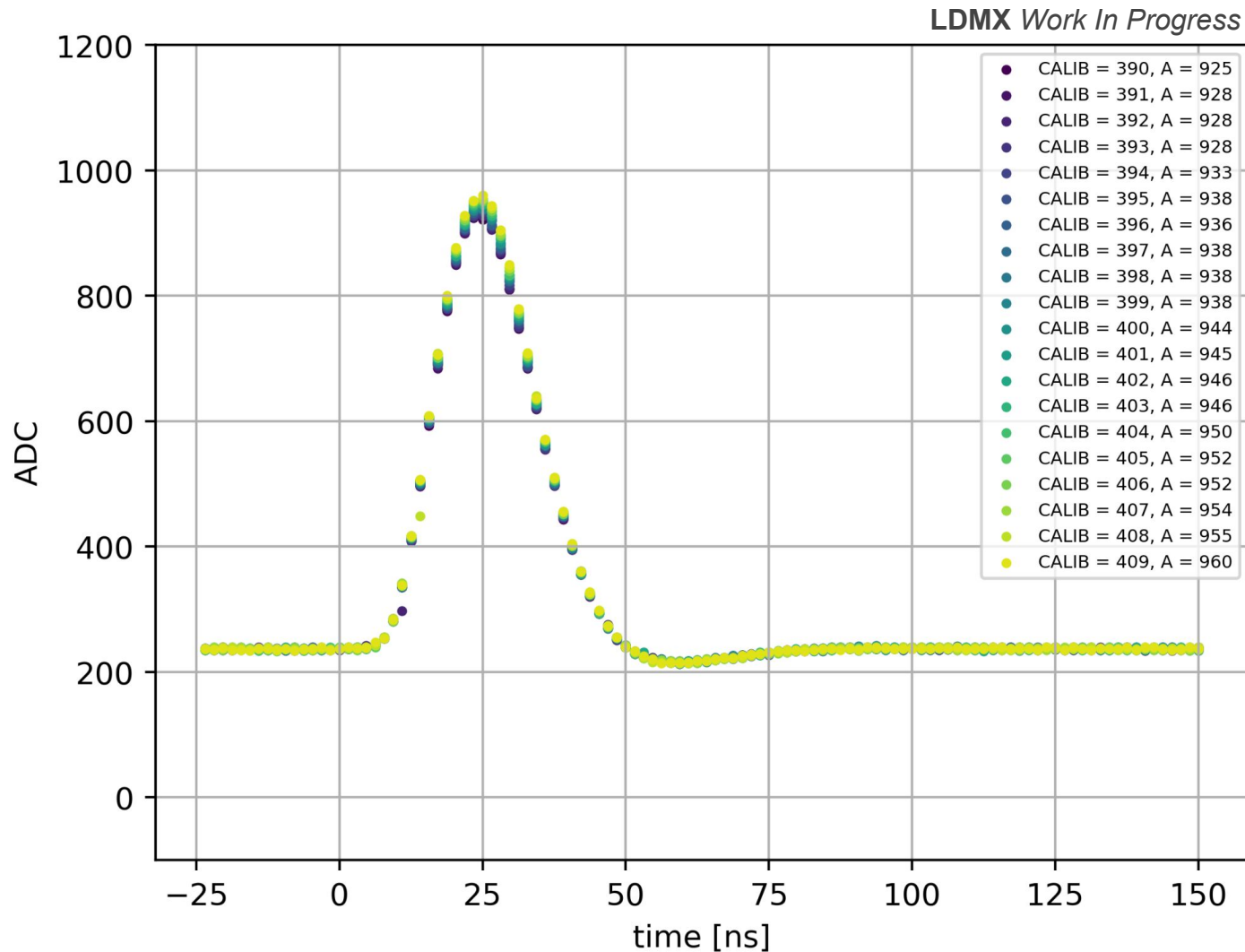
2. Scan TOT threshold parameter.

3. Calculate the TOT efficiency.

4. Iterate steps 2 & 3 until a TOT threshold with 50% efficiency is found.



How to set the TOT threshold: Example



- CALIB was found to be 404.
- The TOT threshold parameter was found to be 383.



Summary and outlook

- ADC is linear!
- We are investigating the jump in TOT.
- We have stable methods for running tests on multiple HGCROC boards. Andreas tested and sent boards for the slice test that showed same electronic performances.
- Andreas is currently working on a method to calibrate the TOT threshold for all channels.





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Backup slides

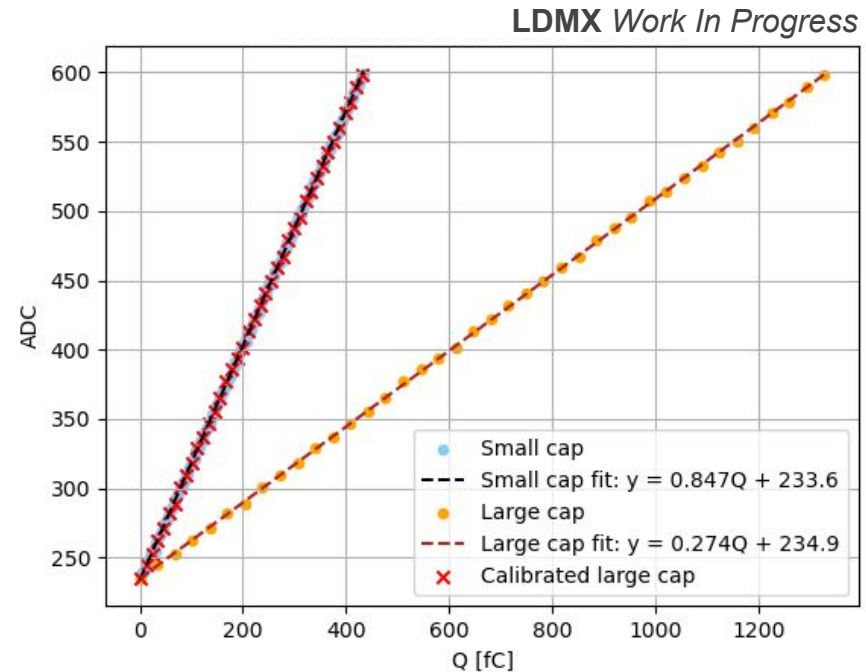


Large capacitor calibration

- Linear fit of both small and large capacitor data
- Require corrected ADC values to be the same as from small capacitor
- Calibrated charge will be:

$$q' = \frac{m_h \cdot q_h + b_h - b_l}{m_l}$$

- Purpose: enables comparison between small and large capacitor



Large capacitor calibration: Derivation

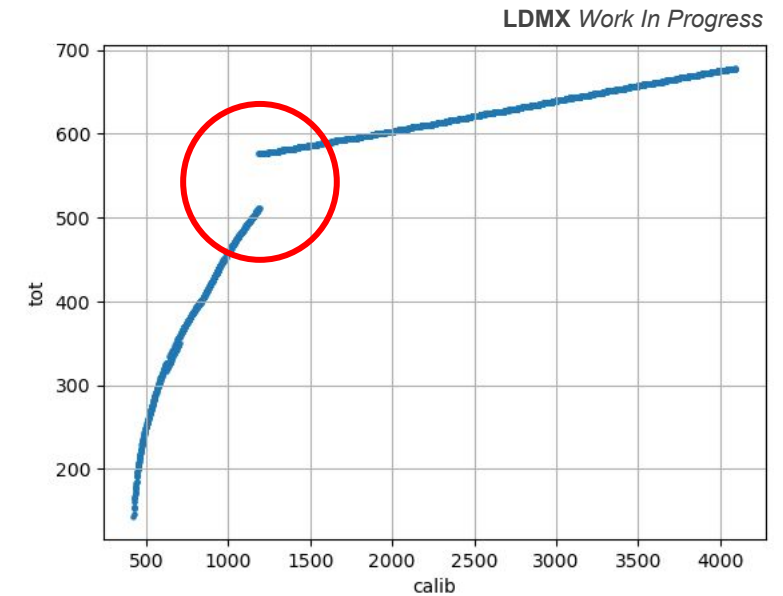
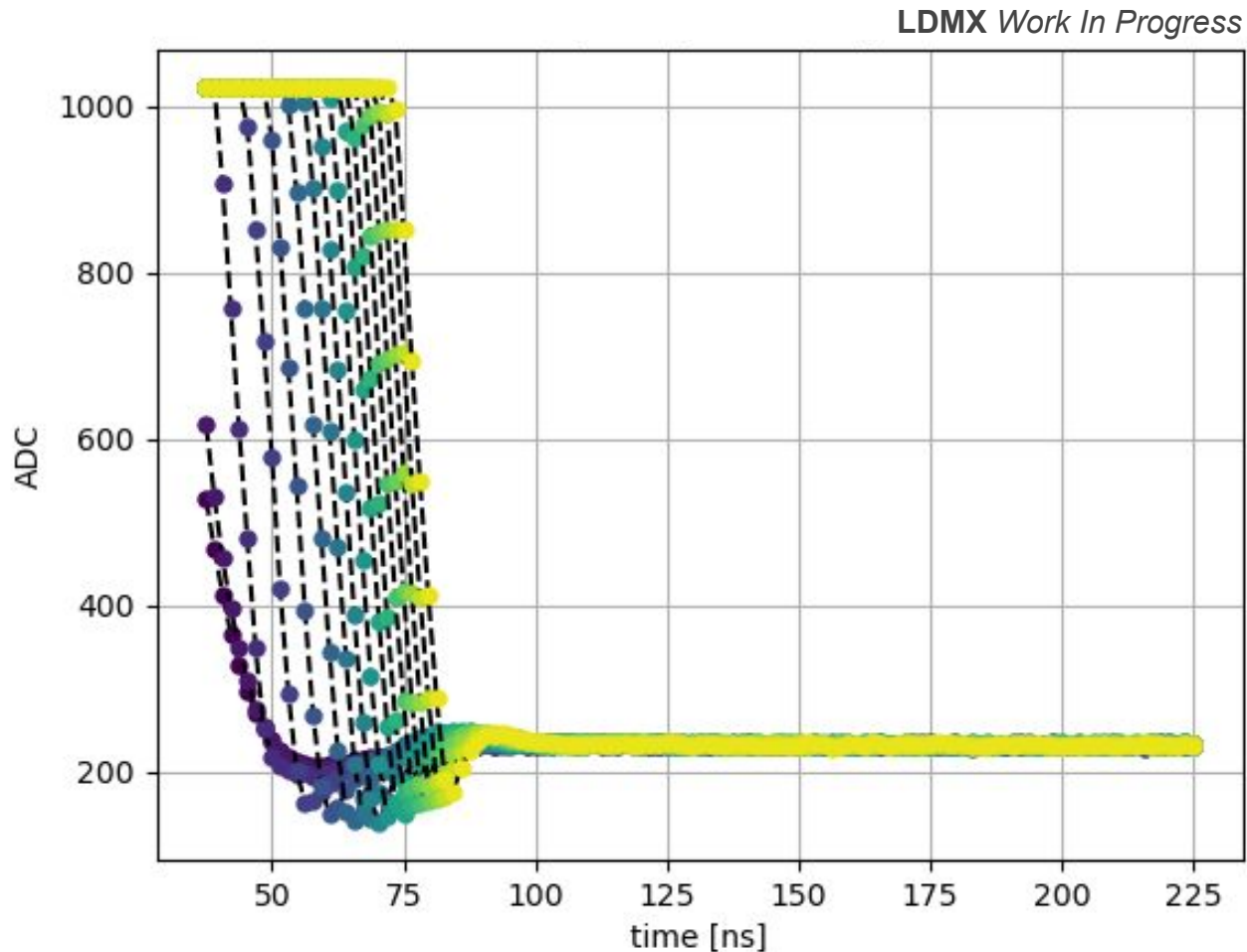
- Assume small capacitor has correct capacitance
- Use that to calibrate the large capacitor
- Define linear fits:
 - large capacitor: $y_h = m_h \cdot q_h + b_h$ (small cap analogously)
- Corrected values have same slope and intercept as small cap:

$$y' = m_l \cdot q' + b_l$$

- Take ADC value from large cap, thus $y' = y_h$
- Solving for q' :
$$q' = \frac{m_h \cdot q_h + b_h - b_l}{m_l}$$
- Plot corrected charge values q' with y_h



The pulse at the “jump”



- There is no observable gap in the region where the TOT jumps.

